

SEMITOP® 3

**IGBT** Module

**SK50GB12T4T** 

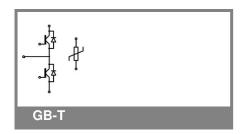
#### **Features**

- One screw mounting module
- Trench4 IGBT technology
- CAL4 technology FWD
- Integrated NTC temperature sensor

### **Typical Applications\***

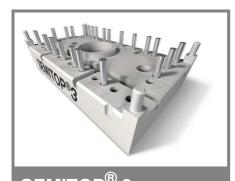
#### Remarks

•  $V_{CE,sat}$ ,  $V_F$  = chip level value



Absolute	Absolute Maximum Ratings T <sub>s</sub> = 25 °C, unless otherwise specified					
Symbol	Conditions			Values	Units	
IGBT			'			
$V_{CES}$	T <sub>j</sub> = 25 °C			1200	V	
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C		71	А	
		$T_s = 70  ^{\circ}C$		56	Α	
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>			150	Α	
$V_{GES}$				± 20	V	
t <sub>psc</sub>	$V_{CC}$ = 800 V; $V_{GE} \le 15$ V; VCES < 1200 V	T <sub>j</sub> = 150 °C		10	μs	
Inverse D	Diode					
I <sub>F</sub>	T <sub>j</sub> = 175 °C	$T_s = 25 ^{\circ}C$		50	Α	
		$T_s = 70  ^{\circ}C$		40	Α	
I <sub>FRM</sub>	I <sub>FRM</sub> = 3 x I <sub>Fnom</sub>			150	Α	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		265	Α	
Module						
$I_{t(RMS)}$					Α	
$T_{vj}$				-40 <b>+</b> 175	°C	
T <sub>stg</sub>				-40 <b>+</b> 125	°C	
V <sub>isol</sub>	AC, 1 min.			2500	V	

Characteristics $T_s =$			25 °C, unless otherwise specified			
Symbol	Conditions		min.	typ.	max.	Units
IGBT	•					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 1.7 \text{ mA}$		5	5,8	6,5	V
I <sub>CES</sub>	$V_{GE} = 0 \text{ V}, V_{CE} = V_{CES}$	T <sub>j</sub> = 25 °C			1,0	mA
		T <sub>j</sub> = 125 °C				mA
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = 20 V	T <sub>j</sub> = 25 °C			600	nA
		T <sub>j</sub> = 125 °C				nA
$V_{CE0}$		T <sub>j</sub> = 25 °C		1,1	1,3	V
		T <sub>j</sub> = 150 °C		1	1,2	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C		15		mΩ
		T <sub>j</sub> = 150°C		25		$m\Omega$
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 50 A, V <sub>GE</sub> = 15 V			1,85	2,05	V
		$T_j = 150^{\circ}C_{chiplev.}$		2,25	2,45	V
C <sub>ies</sub>				2,77		nF
$C_{oes}$	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,2		nF
C <sub>res</sub>				0,16		nF
$Q_G$	V <sub>GE</sub> =-7V+15V			375		nC
R <sub>Gint</sub>	T <sub>i</sub> = 25 °C			4		Ω
t <sub>d(on)</sub>				63		ns
t,	$R_{Gon} = 32 \Omega$	V <sub>CC</sub> = 600V		65		ns
Ė <sub>on</sub>	di/dt = 920 A/μs	I <sub>C</sub> = 50A		8,3		mJ
<sup>L</sup> d(off)	$R_{Goff} = 32 \Omega$ di/dt = 920 A/µs	T <sub>j</sub> = 150 °C		521 80		ns
t <sub>f</sub>	αι/αι = 920 A/μs	V <sub>GE</sub> = ±15 V		80		ns
E <sub>off</sub>				5		mJ
$R_{th(j-s)}$	per IGBT			0,9		K/W



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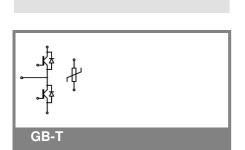
F	ea	tu	re	S
•	Cu	LU		•

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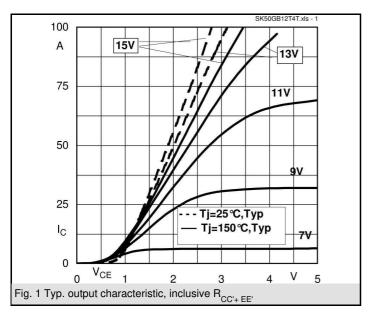
### **Typical Applications\***

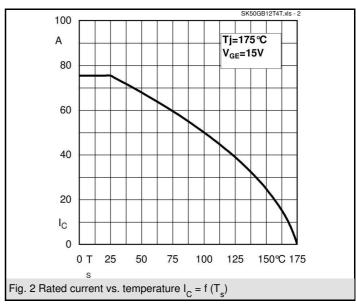
### **Remarks**

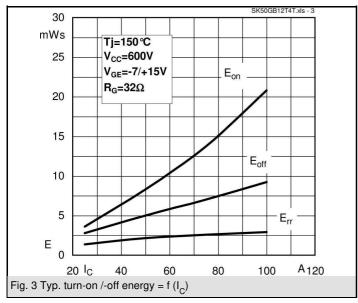
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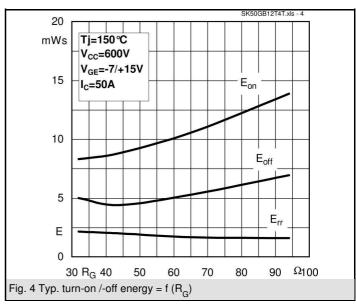


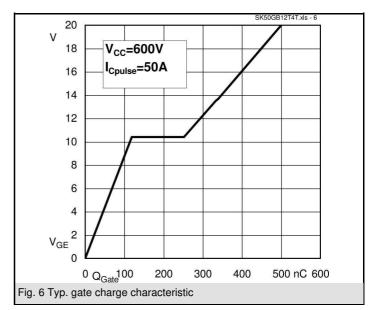
Characteristics						
Symbol	Conditions	ĺ	min.	typ.	max.	Units
Inverse Diode						
$V_F = V_{EC}$	$I_{Fnom}$ = 50 A; $V_{GE}$ = 0 V			2,2	2,55	V
		T <sub>j</sub> = 150 °C <sub>chiplev.</sub>		2,18	2,5	V
$V_{F0}$		T <sub>j</sub> = 25 °C		1,3	1,5	V
		T <sub>j</sub> = 150 °C		0,9	1,1	V
r <sub>F</sub>		T <sub>j</sub> = 25 °C		19	21	mΩ
		T <sub>j</sub> = 150 °C		26	28	$m\Omega$
I <sub>RRM</sub>	I <sub>F</sub> = 50 A	T <sub>i</sub> = 150 °C		30		Α
$Q_{rr}$	di/dt = 920 A/µs			7,2		μC
E <sub>rr</sub>	V <sub>CC</sub> = 600V			2,15		mJ
R <sub>th(j-s)D</sub>	per diode			1,24		K/W
M <sub>s</sub>	to heat sink				2,5	Nm
w				30		g
Temperature sensor						
R <sub>100</sub>	$T_s$ =100°C ( $R_{25}$ =5kΩ)			493±5%		Ω

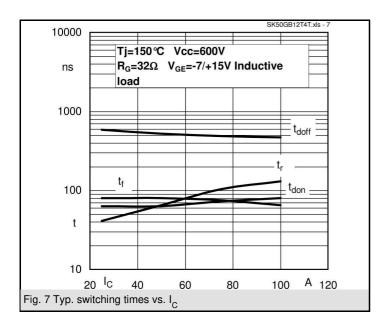


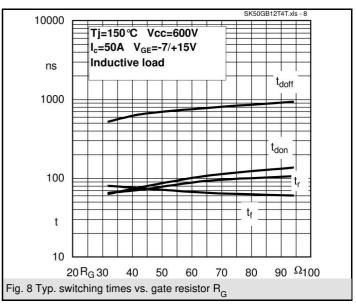


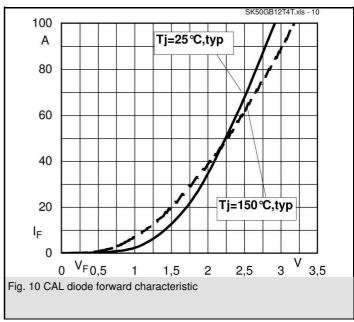


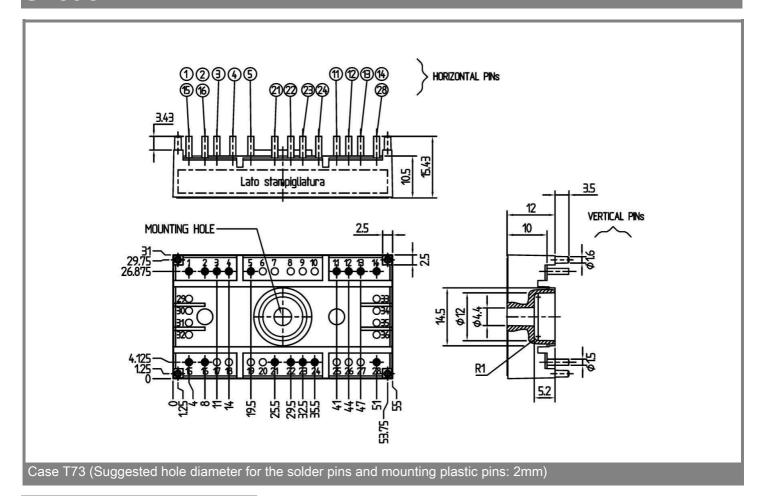


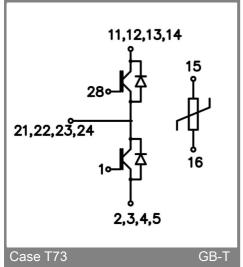












This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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